

HM62W1664H Series

HM62W1864H Series

Preliminary

65536-word × 16/18-bit High Speed CMOS Static RAM

The HM62W1664H/HM62W1864H is an asynchronous 3.3 V operation high speed static RAM organized as 64 kword × 16/18 bit. It realize high speed access time (25/30/35/45 ns) with employing 0.8 μm CMOS process and high speed circuit designing technology.

It is most appropriate for the application which requires high speed, high density memory and wide bit width configuration, such as cache and buffer memory in system.

The HM62W1664H/HM62W1864H is packaged in 400-mil 44-pin SOJ & TSOP-II for high density surface mounting.

Features

- Single 3.3 V supply: 3.3 V ± 0.3 V
- Access time 25/30/35/45 ns (max)
- Completely static memory
 - No clock or timing strobe required
- Equal access and cycle times
- Directly CMOS compatible
 - All inputs and outputs
- 400-mil 44-pin SOJ & TSOP-II package
- Center V_{CC} and V_{SS} type pinout

Ordering Information

Type No.	Access time	Package
HM62W1664HJP-25	25 ns	400-mil 44-pin plastic SOJ (CP-44D)
HM62W1664HJP-30	30 ns	
HM62W1664HJP-35	35 ns	
HM62W1664HJP-45	45 ns	
HM62W1664HLJP-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1664HLJP-30	30 ns	
HM62W1664HLJP-35	35 ns	
HM62W1664HLJP-45	45 ns	
HM62W1864HJP-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1864HJP-30	30 ns	
HM62W1864HJP-35	35 ns	
HM62W1864HJP-45	45 ns	
HM62W1864HLJP-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1864HLJP-30	30 ns	
HM62W1864HLJP-35	35 ns	
HM62W1864HLJP-45	45 ns	
HM62W1664HTT-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1664HTT-30	30 ns	
HM62W1664HTT-35	35 ns	
HM62W1664HTT-45	45 ns	
HM62W1864HTT-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1864HTT-30	30 ns	
HM62W1864HTT-35	35 ns	
HM62W1864HTT-45	45 ns	
HM62W1664HLTT-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1664HLTT-30	30 ns	
HM62W1664HLTT-35	35 ns	
HM62W1664HLTT-45	45 ns	
HM62W1864HLTT-25	25 ns	400-mil 44-pin plastic TSOP-II normal bend type (TTP-44DE)
HM62W1864HLTT-30	30 ns	
HM62W1864HLTT-35	35 ns	
HM62W1864HLTT-45	45 ns	

Note: The specifications of this device are subject to change without notice. Please contact your nearest Hitachi's Sales Dept. regarding specifications.

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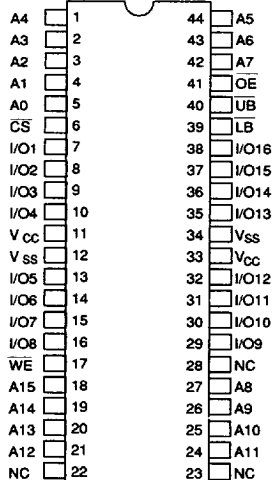
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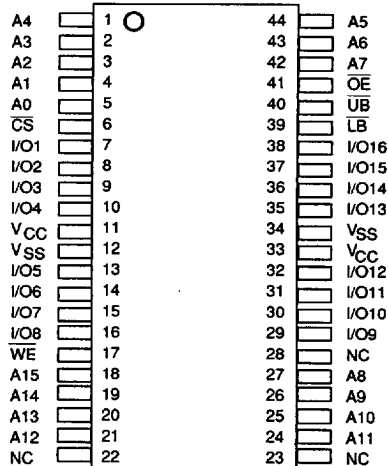
Pin Arrangement

HM62W1664HJP (SOJ)



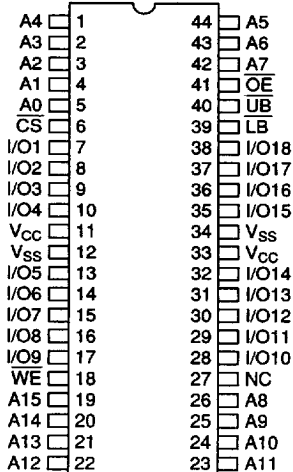
(Top View)

HM62W1664HTT
(Normal Bend TSOP-II)



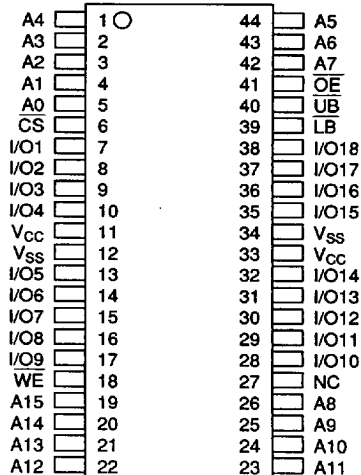
(Top View)

HM62W1864HJP (SOJ)



(Top View)

HM62W1864HTT
(Normal Bend TSOP-II)



(Top View)

HM62W1664H/HM62W1864H Series

Pin Description

Pin name

HM62W1664H	HM62W1864H	Function
A0 – A15	A0 – A15	Address
I/O1 – I/O8	I/O1 – I/O9	Input/output (lower byte)
I/O9 – I/O16	I/O10 – I/O18	Input/output (upper byte)
$\overline{\text{CS}}$	$\overline{\text{CS}}$	Chip select
LB	LB	Lower byte select
UB	UB	Upper byte select
WE	WE	Write enable
OE	OE	Output enable
V _{CC}	V _{CC}	Power supply
V _{SS}	V _{SS}	Ground
NC	NC	No connection

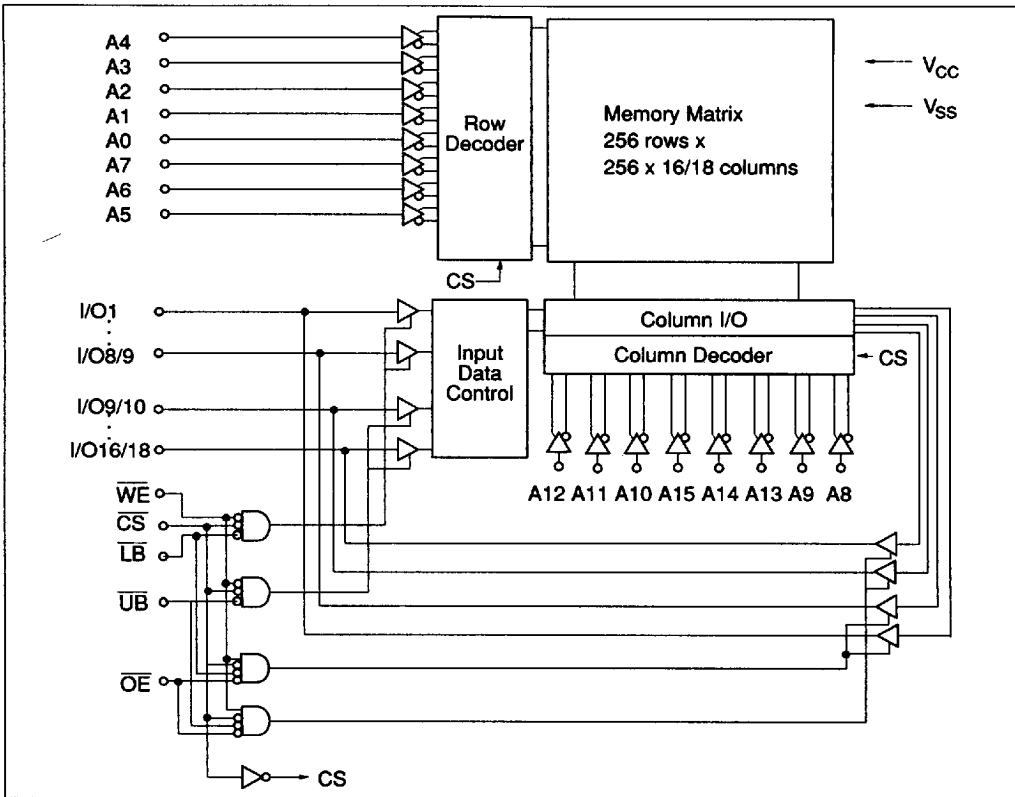
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Block Diagram



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Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Supply voltage relative to V_{SS}	V_{CC}	-0.5 to +4.6	V
Voltage on any pin relative to V_{SS}	V_T	-0.5 *1 to $V_{CC} + 0.5$	V
Power dissipation	P_T	1.0	W
Operating temperature	T_{opr}	0 to +70	°C
Storage temperature	T_{stg}	-55 to +125	°C
Storage temperature under bias	T_{bias}	-10 to +85	°C

Note: 1. -2.5 V for pulse width (under stoot) ≤ 10 ns

HM62W1664H/HM62W1864H Series

Function Table

CS	OE	WE	LB	UB	V _{CC} current	I/O (Lower byte)	I/O (Upper byte)	Ref. cycle
H	X	X	X	X	I _{SB} , I _{SB1}	High-Z	High-Z	—
L	H	H	X	X	I _{CC}	High-Z	High-Z	—
L	L	H	L	L	I _{CC}	Output	Output	Read cycle
L	L	H	L	H	I _{CC}	Output	High-Z	Read cycle
L	L	H	H	L	I _{CC}	High-Z	Output	Read cycle
L	L	H	H	H	I _{CC}	High-Z	High-Z	—
L	X	L	L	L	I _{CC}	Input	Input	Write cycle
L	X	L	L	H	I _{CC}	Input	High-Z	Write cycle
L	X	L	H	L	I _{CC}	High-Z	Input	Write cycle
L	X	L	H	H	I _{CC}	High-Z	High-Z	—

Note: 1. X: H or L

Recommended DC Operating Conditions (Ta = 0 to +70°C)

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage*2	V _{CC}	3.0	3.3	3.6	V
	V _{SS}	0	0	0	V
Input voltage	V _{IH}	2.0	—	V _{CC} + 0.3	V
	V _{IL}	-0.3 *1	—	0.8	V

- Note: 1. -2.0 V for pulse width (under shoot) ≤ 10 ns
 2. The supply voltage with all V_{CC} pins must be on the same level.
 The supply voltage with all V_{SS} pins must be on the same level.

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HM62W1664H/HM62W1864H Series

DC Characteristics ($T_a = 0$ to $+70^\circ\text{C}$, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$, $V_{SS} = 0 \text{ V}$)

Parameter	Symbol	Min	Typ ^{*1}	Max	Unit	Test conditions	Notes
Input leakage current	$ I_{LI} $	—	—	2	μA	$V_{in} = V_{SS}$ to V_{CC}	
Output leakage current	$ I_{LO} $	—	—	2	μA	$V_{I/O} = V_{SS}$ to V_{CC}	1
Operating power supply current	I_{CC}	—	90	120	mA	25 ns cycle	$\overline{CS} = V_{IL}$, $I_{out} = 0 \text{ mA}$ Other inputs $= V_{IH}/V_{IL}$
		—	80	110	mA	30 ns cycle	
		—	70	100	mA	35 ns cycle	
		—	60	90	mA	45 ns cycle	
Standby power supply current	I_{SB}	—	20	40	mA	25 ns cycle	$\overline{CS} = V_{IH}$, Other inputs $= V_{IH}/V_{IL}$
		—	18	35	mA	30 ns cycle	
		—	15	30	mA	35 ns cycle	
		—	13	25	mA	45 ns cycle	
Standby power supply current (1)	I_{SB1}	—	—	1	mA	$V_{CC} \geq \overline{CS} \geq V_{CC} - 0.2 \text{ V}$, $0 \text{ V} \leq V_{in} \leq 0.2 \text{ V}$ or	L-version
		—	—	0.06	mA	$V_{CC} \geq V_{in} \geq V_{CC} - 0.2 \text{ V}$	
Output voltage	V_{OL1}	—	—	0.2	V	$I_{OL1} = 0.1 \text{ mA}$	
	V_{OL2}	—	—	0.4	V	$I_{OL2} = 2 \text{ mA}$	
	V_{OH1}	$V_{CC} - 0.2$	—	—	V	$I_{OH1} = -0.1 \text{ mA}$	
	V_{OH2}	2.4	—	—	V	$I_{OH2} = -2 \text{ mA}$	

Note: 1. Typical values are at $V_{CC} = 3.3 \text{ V}$, $T_a = +25^\circ\text{C}$ and specified loading.

Capacitance ($T_a = 25^\circ\text{C}$, $f = 1.0 \text{ MHz}$)*¹

Parameter	Symbol	Min	Typ	Max	Unit	Test conditions
Input capacitance	C_{in}	—	—	6	pF	$V_{in} = 0 \text{ V}$
Input/output capacitance	$C_{I/O}$	—	—	8	pF	$V_{I/O} = 0 \text{ V}$

Note: 1. This parameter is sampled and not 100% tested.

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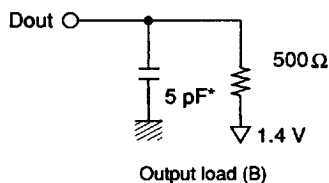
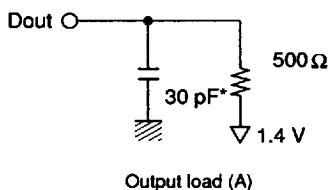
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HM62W1664H/HM62W1864H Series

AC Characteristics ($T_a = 0$ to $+70^\circ\text{C}$, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$, unless otherwise noted.)

Test Conditions

- Input pulse levels: $2.4 \text{ V} / 0.4 \text{ V}$
- Input rise and fall times: 3 ns
- Input and output timing reference levels: 1.4 V
- Output load: See figures



(for t_{CLZ} , t_{OLZ} , t_{LBLZ} , t_{UBLZ} , t_{CHZ} , t_{OHZ} ,
 t_{LBHZ} , t_{UBHZ} , t_{WHZ} , and t_{OW})

* Including scope and jig

Read Cycle

HM62W1664H/HM62W1864H

Parameter	Symbol	-25		-30		-35		-45		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	
Read cycle time	t_{RC}	25	—	30	—	35	—	45	—	ns
Address access time	t_{AA}	—	25	—	30	—	35	—	45	ns
Chip select access time	t_{ACS}	—	25	—	30	—	35	—	45	ns
Output enable to output valid	t_{OE}	—	15	—	15	—	20	—	25	ns
Byte select to output valid	t_{LB} , t_{UB}	—	15	—	15	—	20	—	25	ns
Output hold from address change	t_{OH}	5	—	5	—	—	5	—	—	ns
Chip select to output in low-Z	t_{CLZ}	5	—	5	—	5	—	5	—	ns
Output enable to output in low-Z	t_{OLZ}	1	—	1	—	1	—	1	—	ns
Byte select to output in low-Z	t_{LBLZ} , t_{UBLZ}	1	—	1	—	1	—	1	—	ns
Chip deselect to output in high-Z	t_{CHZ}	—	12	—	12	—	12	—	12	ns

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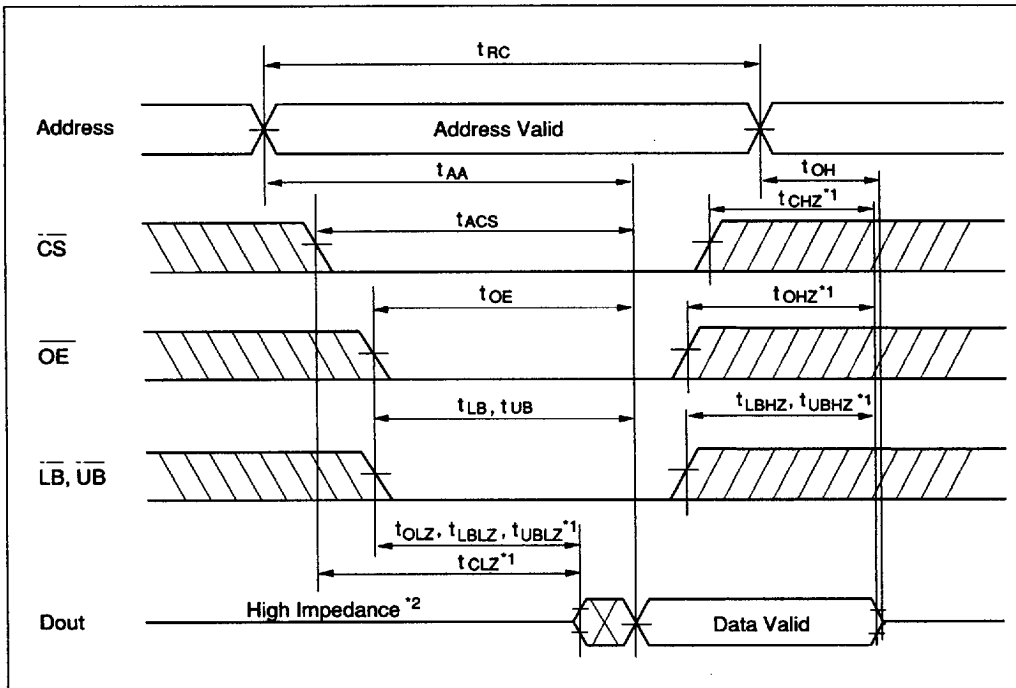
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HM62W1664H/HM62W1864H Series

Read Cycle (cont)

		HM62W1664H/HM62W1864H								
		-25		-30		-35		-45		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Output disable to output in high-Z	t _{OHZ}	—	12	—	12	—	12	—	12	ns
Byte deselect to output in high-Z	t _{LBHZ} , t _{UBHZ}	—	12	—	12	—	12	—	12	ns

Read Timing Waveform *3



- Notes:
1. Transition is measured ± 200 mV from steady state's voltage with Load (B). This parameter is sampled and not 100% tested.
 2. When CS, OE, and LB are low, Dout (lower byte) is low impedance. When CS, OE, and UB are low, Dout (upper byte) is low impedance.
 3. WE is high for read cycle.

HM62W1664H/HM62W1864H Series

Write Cycle

		HM62W1664H/HM62W1864H									
		-25		-30		-35		-45			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	
Write cycle time	t_{WC}	25	—	30	—	35	—	45	—	ns	
Address valid to end of write	t_{AW}	20	—	20	—	25	—	30	—	ns	
Chip select to end of write	t_{CW}	20	—	20	—	25	—	30	—	ns	
Write pulse width	t_{WP}	20	—	20	—	25	—	30	—	ns	
Byte select to end of write	t_{LBW}, t_{UBW}	20	—	20	—	25	—	30	—	ns	
Address setup time	t_{AS}	0	—	0	—	0	—	0	—	ns	
Write recovery time	t_{WR}	0	—	0	—	0	—	0	—	ns	
Data to write time overlap	t_{DW}	15	—	15	—	20	—	25	—	ns	
Data hold from write time	t_{DH}	0	—	0	—	0	—	0	—	ns	
Write disable to output in low-Z	t_{OW}	5	—	5	—	5	—	5	—	ns	
Write enable to output in high-Z	t_{WHZ}	—	12	—	12	—	12	—	12	ns	

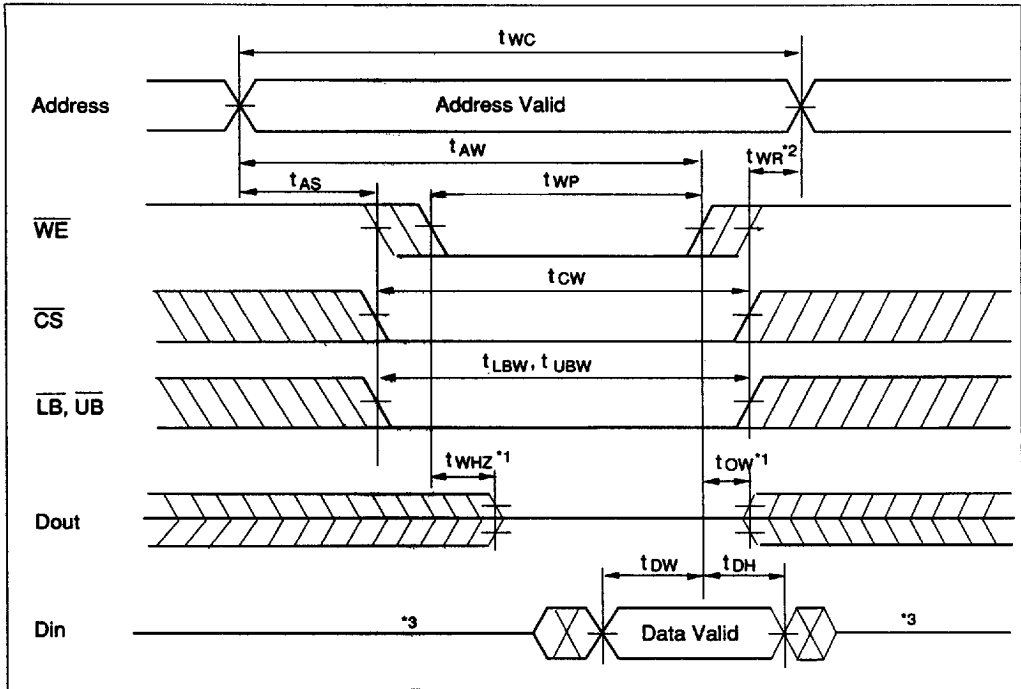
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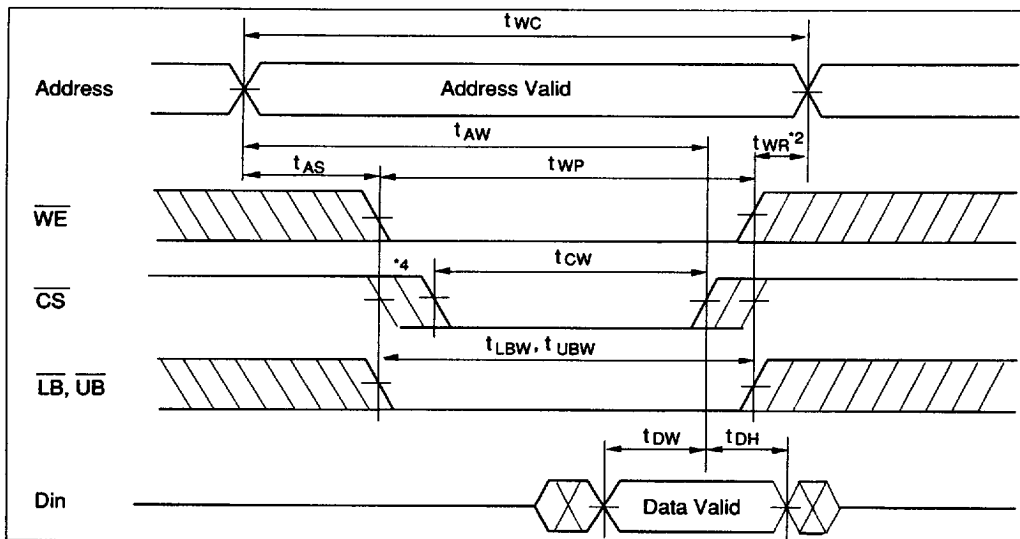
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Write Timing Waveform (1) ($\overline{WE}$ Controlled)

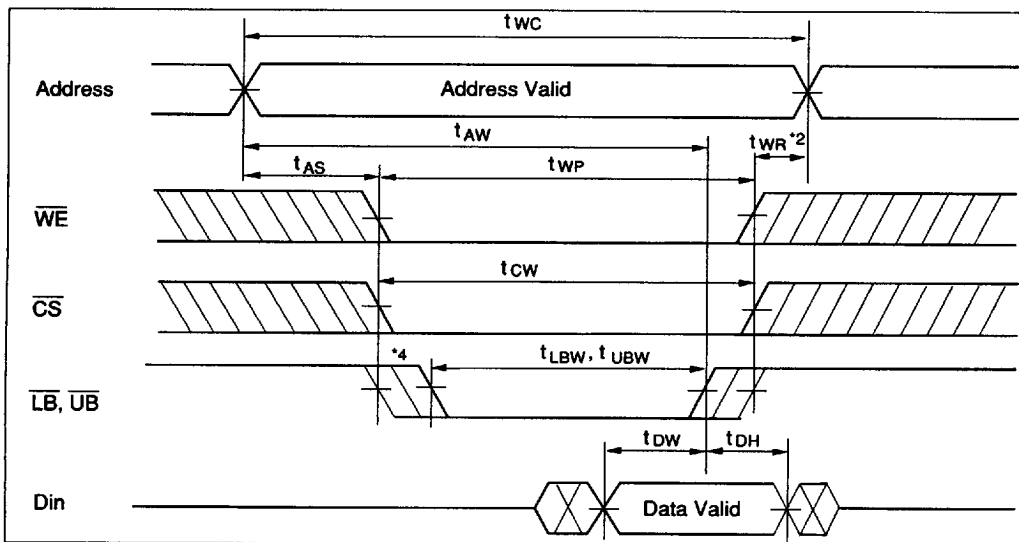


HM62W1664H/HM62W1864H Series

Write Timing Waveform (2) ($\overline{CS}$ Controlled)



Write Timing Waveform (3) ($\overline{LB}$, $\overline{UB}$ Controlled)



- Notes:
1. Transition is measured ± 200 mV from high impedance state's voltage with Load (B). This parameter is sampled and not 100% tested.
 2. $\overline{WE}$ must be high during address transition except when the device is disabled with $\overline{CS}$, $\overline{LB}$, or $\overline{UB}$.
 3. If $\overline{CS}$, $\overline{OE}$, $\overline{LB}$, and $\overline{UB}$ are low during this period, I/O pins are in the output state. Then, the data input signals of opposite phase to the outputs must not be applied to them.
 4. If the $\overline{CS}$ or $\overline{LB}$ or $\overline{UB}$ low transition occurs simultaneously with the $\overline{WE}$ low transition or after the $\overline{WE}$ transition, output remains a high impedance state.

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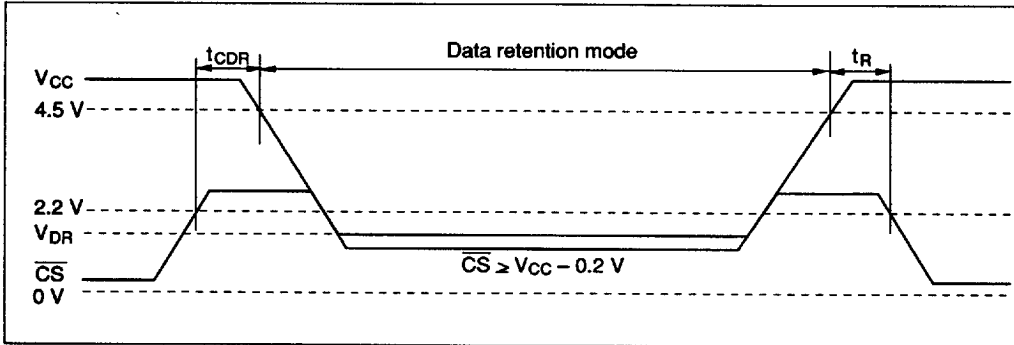
Low V_{CC} Data Retention Characteristics ($T_a = 0$ to $+70^{\circ}\text{C}$)

This characteristics is guaranteed only for L-version.

Parameter	Symbol	Min	Typ	Max	Unit	Test conditions
V_{CC} for data retention	V_{DR}	2.0	—	—	V	$V_{CC} \geq \overline{CS} \geq V_{CC} - 0.2 \text{ V}$
Data retention current	I_{CCDR}	—	2	50 ¹	μA	$V_{CC} \geq V_{in} \geq V_{CC} - 0.2 \text{ V}$ or $0 \text{ V} \leq V_{in} \leq 0.2 \text{ V}$
Chip deselect to data retention time	t_{CDR}	0	—	—	ns	
Operation recovery time	t_R	5	—	—	ms	

Note: 1. $V_{CC} = 3.0 \text{ V}$

Low V_{CC} Data Retention Timing Waveform



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